

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/010,682	CHU ET AL.	
Examiner	Art Unit	
F. Lin Khoo	2664	

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	352	11/2/2005	FLK
370	395.52	11/2/2005	FLK
370	310.1	11/2/2005	FLK
370	310.2	11/2/2005	FLK
370	433	11/2/2005	FLK
370	517	11/2/2005	FLK
370	555	11/2/2005	FLK
370	560	11/2/2005	FLK

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Update Search	11/2/2005	FLK		